# **Monolithic Amplifier**

CMA-545G1+

50Ω 0.4 to 2.2 GHz

## **The Big Deal**

- Ceramic, Hermetically Sealed, Nitrogen filled
- Low profile case, .045" high
- High Gain, 31.5 dB
- Low Noise Figure, 1.0 dB
- High IP3, 35-37 dBm
- Class 1B HBM ESD rating (500V)



CASE STYLE: DL1721

MIL Screening Available
Please consult Applications Dept.

## **Product Overview**

Mini-Circuits CMA-545G1+ is a E-PHEMT based Low Noise MMIC Amplifier operating from 0.4 to 2.2 GHz with a unique combination of low noise and high IP3 making this amplifier ideal for sensitive receiver applications. This design operates on a single +5V supplyand is internally matched to 50 ohms. The MMIC amplifier is bonded to a multilayer integrated LTCC substrate and then hermetically sealed under a controlled nitrogen atmosphere with gold-plated covers and eutectic AuSn solder. These amplifiers are capable of meeting MIL requirements for gross leak, fine leak, thermal shock, vibration, acceleration, mechanical shock, and HTOL. The testing can be done if requested.

# **Key Features**

Feature		Advantages		
High Gain	25-32 dB	Incorporating multiple stages of amplification, the CMA-545G1+ provides high gain reducing cost and PCB board space.		
Ultra Low Noise:	0.8 dB NF at 0.9 GHz	Excellent Noise Figure, measured in a 50 Ohm environment – without any external matching. When combined with high gain of this design, it suppresses second stage NF contribution.		
High IP3:	+36 dBm IP3 at 0.9 GHz	Combining Low Noise and High IP3 makes this MMIC amplifier ideal for Low Noise Receiver Front End (RFE) giving the user advantages at both ends of the dynamic range: sensitivity & two-tone IM dynamic range		
Output Power:	+22 dBm at 0.9 GHz	The CMA-545G1+ maintains consistent output power capability over the full operating temperature range making it ideal to be used in remote applications such as LNB's as the L Band driver stage		
Internally Matched		No external matching elements required to achieve the advertized noise and output power over the full band		
Ceramic Hermetic Package		Low Inductance, repeatable transitions, excellent reliability		
Max Input Power +25 dBm		Ruggedized design operates up to input powers often seen at Receiver inputs.		
High Reliability		Low, small signal operating current of 160 mA nominal maintains junction temperatures typically below 130°C at 85°C ground lead temperature		

# **Monolithic Amplifier**

0.4-2.2 GHz

#### **Product Features**

- High Gain, 32 dB typ. at 0.9 GHz
- Ultra Low Noise Figure, 0.8 dB typ. at 0.9 GHz
- High IP3, 36 dBm typ. at 0.9 GHz
- High Pout, P1dB up to 22 dBm typ. at 0.9 GHz
- Single Positive Supply Voltage, 5V
- Class 1B HBM ESD rating (500V)
- Small size 3mm x 3mm x 1.14mm
- Ceramic, hermetic, Nitrogen filled
- No external matching components required

### **Typical Applications**

- Cellular
- ISM
- GSM
- WCDMA
- LTE
- GPS



CASE STYLE: DL1721

CMA-545G1+

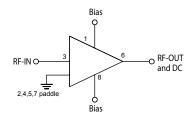
#### +RoHS Compliant

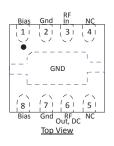
The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

### **General Description**

CMA-545G1+ is a high dynamic range, low noise, high IP3, high output power, monolithic amplifier. Manufactured using E-PHEMT\* technology enables it to work with a single positive supply voltage. Unconditionally stable over the operating frequency. Terminal finish is Ni-Pd-Au and it has repeatable performance from lot to lot due to fully automated, tightly controlled semiconductor and assembly processes.

#### simplified schematic and pad description





Function	Pad Number	Description (See Application Circuit, Fig. 2)
RF-IN	3	RF input pad (connected to RF-IN via C1)
RF-OUT & DC	6	RF output pad (connected to RF-OUT via blocking external cap C2, and Supply voltage Vs via RF Choke L2)
BIAS	1 & 8	Bias pad 1 connects to Vs via L1 & pad 8 connects to Vs
GND	bottom paddle 2&7	Connected to ground
NOT USED	4,5	No internal connection; recommend connecting to ground

<sup>\*</sup>Enhancement mode Pseudomorphic High Electron Mobility Transistor.



## Electrical Specifications<sup>(1)</sup> at 25°C, Vd=5V, Zo=50Ω, (refer to characterization circuit)

Parameter	Condition (GHz)	Min.	Тур.	Max.	Units
Frequency Range		0.4		2.2	GHz
	0.4		1.0		
	0.9		0.8		
Noise Figure	1.2		0.9		dB
· ·	1.6		1.1		
	2.2		1.2		
	0.4	_	32.3	_	+
	0.9	_	31.8	_	
Gain	1.2	28.1	31.6	34.5	dB
	1.6	_	30.0	_	
	2.2	_	25.4	_	
	0.4		15.3		dB
	0.9		9.1		
Input Return Loss	1.2		9.7		
·	1.6		12.2		
	2.2		16.5		
	0.4		21.3		+
	0.9		17.1		
Output Return Loss	1.2		14.7		dB
	1.6		14.2		
	2.2		21.5		
	0.4		35.7		
	0.9		36.1		
Output IP3	1.2		36.5		dBm
	1.6		37.2		
	2.2		37.3		
	0.4	_	22.1	_	dBm
	0.9	_	22.8	_	
Output Power @1 dB Compression(2)	1.2	20.0	23.3	_	
	1.6	_	23.7	_	
	2.2		23.4		
DC Volts (Vd)		4.8	5.0	5.2	V
DC Current (Id)			158	186	mA
DC Current Variation Vs. Temperature <sup>(3)</sup>			-0.156		mA/°C
DC Current Variation Vs. Voltage			0.027		mA/mV
Thermal Resistance <sup>(5)</sup>			48		°C/W

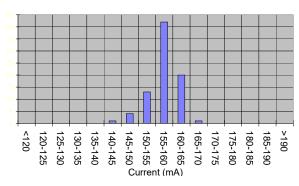
<sup>(1)</sup> Measured on Mini-Circuits Characterization test board TB-758+. See Characterization Test Circuit (Fig. 1)

## **Absolute Maximum Ratings**(4)

Parameter	Ratings		
Operating Temperature <sup>(5)</sup>	-55°C to 105°C		
Storage Temperature	-65°C to 125°C		
Channel Temperature	150°C		
DC Voltage	6V		
Power Dissipation	1.35 W		
Input Power	25 dBm		

<sup>(4)</sup> Permanent damage may occur if any of these limits are exceeded.

#### DC Current Histogram



<sup>(2)</sup> Current increases at P1dB (3) (Current at 85°C - Current at -45°C)/130

These maximum ratings are not intended for continuous normal operation. (5) Defined with reference to ground pad temperature.

#### **Characterization Test Circuit**

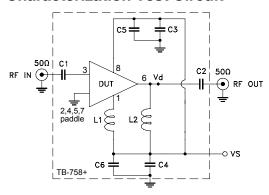
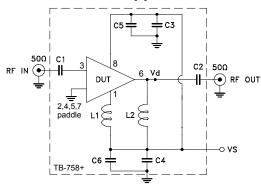


Fig 1. Block Diagram of Test Circuit used for characterization. (DUT soldered on Mini-Circuits Characterization Test Board TB-758+) Gain, Output power at 1dB compression (P1dB), Output IP3 (OIP3), Noise Figure are measured using Agilent's N5242A PNA-X microwave network analyzer.

#### Conditions:

- 1. Gain: Pin=-25 dBm
- 2. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 0 dBm/tone at output.
- 3. Vs adjusted for 5V at device (Vd), compensating loss of bias tee.

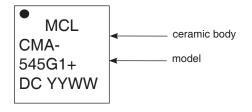
#### **Recommended Application Circuit**



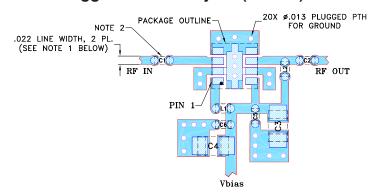
Component	Description		
DUT	CMA-545G1+		
C1, C2, C5, C6	100 pF		
C3, C4	1μF		
L1	36 nH		
L2	47 nH		

Fig 2. Recommended Application Circuit

# **Product Marking**



## Suggested PCB Layout (PL-405)



- NOTES: 1. TRACE WIDTH IS SHOWN FOR ROGERS RO4350B WITH DIELECTRIC THICKNESS .010" ± .001"; COPPER: 1/2 OZ. EACH SIDE.
  FOR OTHER MATERIALS TRACE WIDTH MAY NEED TO BE MODIFIED.
  2. 0402 AND 0805 SIZE CHIP FOOT PRINTS SHOWN FOR REFERENCE,
  FOR COMPONENT VALUE REFER TO TB-758+.
  3. BOTTOM SIDE OF THE PCB IS CONTINUOUS GROUND PLANE.

  - DENOTES PCB COPPER LAYOUT WITH SMOBC (SOLDER MASK OVER BARE COPPER)
    - DENOTES COPPER LAND PATTERN FREE OF SOLDER MASK